

Shenzhen CTA Testing Technology Co., Ltd.

Room 106, Building 1, Yibaolai Industrial Park, Qiaotou Community, Fuhai Street, Bao'an District, Shenzhen, China

RF Exposure MPE

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Date of issue Aug. 30, 2025

Testing Laboratory Name Shenzhen CTA Testing Technology Co., Ltd.

Room 106, Building 1, Yibaolai Industrial Park, Qiaotou Community,

Fuhai Street, Bao'an District, Shenzhen, China

Applicant's name...... Beijing Silion Technology Corp.,LTD.

Address...... 5 Floor, Building A, No.3 Longyu North St., Changping District,

Beijing, 102200 China

KDB447498 D01 General RF Exposure Guidance v06

CTATE!

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Test item description RFID module

Trade Mark N/A

Manufacturer Beijing Silion Technology Corp.,LTD.

Model/Type reference SIM7400

Listed Models N/A

Rating DC 5.0V from external circuit

Result: PASS

Shenzhen CTA Testing Technology Co., Ltd.

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TEST REPORT

Equipment under Test : RFID module

Model /Type : SIM7400

Listed Models : N/A

Applicant : Beijing Silion Technology Corp.,LTD.

Address 5 Floor, Building A, No.3 Longyu North St., Changping District,

Beijing, 102200 China

Manufacturer : Beijing Silion Technology Corp.,LTD.

Address : 5 Floor, Building A, No.3 Longyu North St., Changping District,

Beijing, 102200 China

Test Result: PASS

The test report merely corresponds to the test sample. It is not permitted to copy extracts of these test result without the written permission of the test laboratory.

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TEST STANDARDS

The tests were performed according to following standards:

ANSI C95.1-1999: IEEE Standard for Safety Levels with Respect to Human Exposure to Radio Frequency Electromagnetic Fields, 3 kHz to 300 GHz.

FCC KDB 447498 D01 General RF Exposure Guidance v06: Mobile and Portable Device, RF Exposure, Equipment Authorization Procedures.

FCC CFR 47 part1 1.1310: Radiofrequency radiation exposure limits.

FCC CFR 47 part2 2.1091: Radiofrequency radiation exposure evaluation: mobile devices

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SUMMARY

General Remarks

Date of receipt of test sample	. 1	Aug. 16, 2025		NG
and the state of t	C,			GTIN
Testing commenced on	:	Aug. 16, 2025		TES
200			C.	
Testing concluded on	:	Aug. 30, 2025	(SA)	

2.2 Product Description

Testing concluded on	: Aug. 30, 2025			
2.2 Product Descrip	tion			
Product Name:	RFID module			
Model/Type reference:	SIM7400			
Power supply:	DC 5.0V from external circuit			
Hardware version:	SIM7400_REV7			
Software version:	25.07.14.01			
Testing sample ID:	CTA250816013-1# (Engineer sample), CTA250816013-2# (Normal sample)			
RFID				
Modulation Technology:	ASK			
Operation frequency:	902.75MHz-927.25MHz			
Channel number:	50			
Antenna type:	External antenna			
Antenna gain:	6 dBi			
Note:	Sixteen antennas were same specification and cannot be used at the same time. Tests were performed on Sixteen antenna ports seperately. The test data at antenna port 1 is the worst case and recorded.			

Special Accessories

The following is the EUT test of the auxiliary equipment provided by the laboratory:

Description	Manufacture r	Model	Technical Parameters	Certificate	Provided by
Adapter	1	EP-TA20CBC	Input: AC 100-240V 50/60Hz Output: DC 5V 2A	1	TESTING
PC	1	E470C	1	CT	1

Modifications 2.4

No modifications were implemented to meet testing criteria. OTATE

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3 TEST ENVIRONMENT

3.1 Address of the test laboratory

Shenzhen CTA Testing Technology Co., Ltd.

Room 106, Building 1, Yibaolai Industrial Park, Qiaotou Community, Fuhai Street, Baoʻan District, Shenzhen, China

3.2 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

FCC-Registration No.: 517856 Designation Number: CN1318

Shenzhen CTA Testing Technology Co., Ltd. has been listed on the US Federal Communications Commission list of test facilities recognized to perform electromagnetic emissions measurements.

A2LA-Lab Cert. No.: 6534.01

Shenzhen CTA Testing Technology Co., Ltd. has been listed by American Association for Laboratory Accreditation to perform electromagnetic emission measurement. The 3m-Semi anechoic test site fulfils CISPR 16-1-4 according to ANSI C63.10 and CISPR 16-1-4:2010.

3.3 Statement of the measurement uncertainty

The data and results referenced in this document are true and accurate. The reader is cautioned that there may be errors within the calibration limits of the equipment and facilities. The measurement uncertainty was calculated for all measurements listed in this test report acc. to TR-100028-01" Electromagnetic compatibility and Radio spectrum Matters (ERM);Uncertainties in the measurement of mobile radio equipment characteristics; Part 1" and TR-100028-02 "Electromagnetic compatibility and Radio spectrum Matters (ERM);Uncertainties in the measurement of mobile radio equipment characteristics; Part 2 " and is documented in the Shenzhen CTA Testing Technology Co., Ltd. quality system acc. to DIN EN ISO/IEC 17025. Furthermore, component and process variability of devices similar to that tested may result in additional deviation. The manufacturer has the sole responsibility of continued compliance of the device.

Hereafter the best measurement capability for Shenzhen CTA Testing Technology Co., Ltd.:

Range	Measurement Uncertainty	Notes	
9KHz~30MHz	3.02 dB	(1)	
30~1000MHz	4.06 dB	(1)	
1~18GHz	5.14 dB	(1)	
18-40GHz	5.38 dB	(1)	
0.15~30MHz	2.14 dB	(1)	STIN
30MHz~18GHz	0.55 dB	(1)	LE-
/	0.57 dB	(1)	
/	1.1%	(1)	
30~1000MHz	4.10 dB	(1)	
1~18GHz	4.32 dB	(1)	
18-40GHz	5.54 dB	(1)	
1	±2%	(1)	
	CTATEST		
	9KHz~30MHz 30~1000MHz 1~18GHz 18-40GHz 0.15~30MHz 30MHz~18GHz / 30~1000MHz 1~18GHz	Range Uncertainty 9KHz~30MHz 3.02 dB 30~1000MHz 4.06 dB 1~18GHz 5.14 dB 18-40GHz 5.38 dB 0.15~30MHz 2.14 dB 30MHz~18GHz 0.55 dB / 0.57 dB / 1.1% 30~1000MHz 4.10 dB 1~18GHz 4.32 dB 18-40GHz 5.54 dB	Range Uncertainty Notes 9KHz~30MHz 3.02 dB (1) 30~1000MHz 4.06 dB (1) 1~18GHz 5.14 dB (1) 18-40GHz 5.38 dB (1) 0.15~30MHz 2.14 dB (1) 30MHz~18GHz 0.55 dB (1) / 0.57 dB (1) / 1.1% (1) 30~1000MHz 4.10 dB (1) 1~18GHz 4.32 dB (1) 18-40GHz 5.54 dB (1)

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<u>Test limit</u>

4.1 Requirement

Limits for Maximum Permissible Exposure (MPE)/Controlled Exposure

	Frequency Range(MHz)	Electric Field Strength(V/m)	Magnetic Field Strength(A/m)	Power Density (mW/cm²)	Averaging Time (minute)
		Limits for Occ	upational/Control	led Exposure	
CTATESTING	0.3 - 3.0 3.0 - 30 30 - 300 300 - 1500 1500 - 100,000	614 1842/f 61.4 /	1.63 4.89/f 0.163 /	(100) * (900/f²)* 1.0 f/300 5	6 6 6 6

Limits for Maximum Permissible Exposure (MPE)/Uncontrolled Exposure

Limits for Maximu	ım Permissible Ex	xposure (MPE)/UI	ncontrolled Expos	sure				
Frequency Range(MHz)	Electric Field Strength(V/m)	Magnetic Field Strength(A/m)	Power Density (mW/cm²)	Averaging Time (minute)	STING			
	Limits for Occ	cupational/Control	led Exposure	Carl Ci				
0.3 - 3.0 3.0 - 30 30 - 300 300 - 1500 1500 - 100,000	614 824/f 27.5 /	1.63 2.19/f 0.073 /	(100) * (180/f ²)* 0.2 f/1500 1.0	30 30 30 30 30 30				
F=frequency in MHz *=Plane-wave equivalent power density								
4.2 MPE Calc	ulation Method	l	C.					

F=frequency in MHz

4.2 MPE Calculation Method

Predication of MPE limit at a given distance Equation from page 18 of OET Bulletin 65, Edition 97-01

S=PG/4πR²

Where: S=power density P=power input to antenna

G=power gain of the antenna in the direction of interest relative to an isotropic radiator

R=distance to the center of radiation of the antenna

4.3 Conducted Power Results

Туре	Channel	Output power (dBm)
	01	29.168
RFID	25	29.199
	50	28.847

^{*=}Plane-wave equivalent power density

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Manufacturing tolerance

RFID ASK (Peak)							
Channel Channel 01 Channel 25 Channel							
Target (dBm)	28.5	28.5	28.5				
Tolerance ±(dB)	1.0	1.0	1.0				
CTATES							
4.5 Standalone MI	PE Result						

4.5 Standalone MPE Result

As declared by the Applicant, the EUT is a wireless device used in a fix application, at least 30 cm from any body part of the user or nearby persons; from the maximum EUT RF output power, the minimum separation distance, r = 30cm, as well as the gain of the used antenna is refer to section 2.2, the RF power density can be obtained.

Modulation Type	Outp dBm	ut power mW	Antenna Gain	Antenna Gain	MPE (mW/cm ²)	MPE Limits			
	ubili ilivv	11177	(dBi)	(linear)	(IIIVV/CIII)	(mW/cm ²)	. C.		
RFID	29.5	891.2509	6.0	3.9811	0.3139	0.601	TING		
CTATES									
Remark: 1. Output power (Peak	k) includi	ing turn-up t	olerance;						

Remark:

- 1. Output power (Peak) including turn-up tolerance;
- 2. MPE evaluate distance is 30cm from user manual provide by manufacturer.

4.6 Simultaneous Transmission for MPE Result

N/A

Conclusion

The measurement results comply with the FCC Limit per 47 CFR 2.1091 for the uncontrolled RF Exposure of mobile device Threshold per KDB 447498 D01v06

Shenzhen CTA Testing Technology Co., Ltd.